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#### Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

### Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

#### Details

Obsolete
PowerPC 603e
1 Core, 32-Bit
266MHz
-
SDRAM
No
-
-
-
-
3.3V
0°C ~ 105°C (TA)
-
357-BBGA
357-PBGA (25x25)
https://www.e-xfl.com/product-detail/nxp-semiconductors/kmpc8241lzq266d

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The peripheral logic integrates a PCI bridge, dual universal asynchronous receiver/transmitter (DUART), memory controller, DMA controller, PIC interrupt controller, a message unit (and  $I_2O$  interface), and an  $I^2C$  controller. The processor core is a full-featured, high-performance processor with floating-point support, memory management, 16-Kbyte instruction cache, 16-Kbyte data cache, and power management features. The integration reduces the overall packaging requirements and the number of discrete devices required for an embedded system.

An internal peripheral logic bus interfaces the processor core to the peripheral logic. The core can operate at a variety of frequencies, allowing the designer to trade performance for power consumption. The processor core is clocked from a separate PLL that is referenced to the peripheral logic PLL, allowing the microprocessor and the peripheral logic block to operate at different frequencies while maintaining a synchronous bus interface. The interface uses a 64- or 32-bit data bus (depending on memory data bus width) and a 32-bit address bus along with control signals that enable the interface between the processor and peripheral logic to be optimized for performance. PCI accesses to the MPC8241 memory space are passed to the processor bus for snooping when snoop mode is enabled.

The general-purpose processor core and peripheral logic serve a variety of embedded applications. The MPC8241 can be used as either a PCI host or PCI agent controller.

# 2 Features

Major features of the MPC8241 are as follows:

- Processor core
  - High-performance, superscalar processor core
  - Integer unit (IU), floating-point unit (FPU) (software enabled or disabled), load/store unit (LSU), system register unit (SRU), and a branch processing unit (BPU)
  - 16-Kbyte instruction cache
  - 16-Kbyte data cache
  - Lockable L1 caches—entire cache or on a per-way basis up to three of four ways
  - Dynamic power management—supports 60x nap, doze, and sleep modes
- Peripheral logic
  - Peripheral logic bus
    - Various operating frequencies and bus divider ratios
    - 32-bit address bus, 64-bit data bus
    - Full memory coherency
    - Decoupled address and data buses for pipelining of peripheral logic bus accesses
    - Store gathering on peripheral logic bus-to-PCI writes
  - Memory interface
    - Up to 2 Gbytes of SDRAM memory
    - High-bandwidth data bus (32- or 64-bit) to SDRAM
    - Programmable timing for SDRAM
    - One to 8 banks of 16-, 64-, 128-, 256-, or 512-Mbit memory devices



# 4 Electrical and Thermal Characteristics

This section provides the AC and DC electrical specifications and thermal characteristics for the MPC8241.

# 4.1 DC Electrical Characteristics

This section covers ratings, conditions, and other characteristics.

### 4.1.1 Absolute Maximum Ratings

This section describes the MPC8241 DC electrical characteristics. Table 1 provides the absolute maximum ratings.

Characteristic <sup>1</sup>	Symbol	Range	Unit
Supply voltage—CPU core and peripheral logic	V <sub>DD</sub>	-0.3 to 2.1	V
Supply voltage—memory bus drivers, PCI and standard I/O buffers	$GV_{DD}OV_{DD}$	–0.3 to 3.6	V
Supply voltage—PLLs	$AV_{DD}/AV_{DD}^2$	-0.3 to 2.1	V
Supply voltage—PCI reference	LV <sub>DD</sub>	-0.3 to 5.4	V
Input voltage <sup>2</sup>	V <sub>in</sub>	-0.3 to 3.6	V
Operational die-junction temperature range	Tj	0 to 105	•C
Storage temperature range	T <sub>stg</sub>	–55 to 150	•C

### Table 1. Absolute Maximum Ratings

#### Notes:

1. Table 2 provides functional and tested operating conditions. Absolute maximum ratings are stress ratings only, and functional operation at the maximums is not guaranteed. Stresses beyond those listed may affect device reliability or cause permanent damage to the device.

2. PCI inputs with  $LV_{DD}$  = 5 V ± 5% V DC may be correspondingly stressed at voltages exceeding  $LV_{DD}$  + 0.5 V DC.





Figure 5. Maximum AC Waveforms for 5-V Signaling

## 4.2 DC Electrical Characteristics

Table 3 provides the DC electrical characteristics for the MPC8241 at recommended operating conditions.

Characteristics	Conditions	Symbol	Min	Мах	Unit	Notes
Input high voltage	PCI only, except PCI_SYNC_IN	V <sub>IH</sub>	$0.65 \times \text{GV}_{\text{DD}} - \text{OV}_{\text{DD}}$	LV <sub>DD</sub>	V	1
Input low voltage	PCI only, except PCI_SYNC_IN	V <sub>IL</sub>		$0.3 \times GV_{DD}OV_{DD}$	V	
Input high voltage	All other pins, including PCI_SYNC_IN (GV <sub>DD</sub> _OV <sub>DD</sub> = 3.3 V)	V <sub>IH</sub>	2.0	3.3	V	
Input low voltage	All inputs, including PCI_SYNC_IN	V <sub>IL</sub>	GND/GNDRING	0.8	V	2
Input leakage current for pins using DRV_PCI driver	$0.5 V \le V_{in} \le 2.7 V$ @ LV <sub>DD</sub> = 4.75 V	۱ <sub>L</sub>	_	±70	μA	3
Input leakage current all others	$      LV_{DD} = 3.6 V \\       GV_{DD} = OV_{DD} \le 3.465 V $	۱ <sub>L</sub>	_	±10	μA	3
Output high voltage	$I_{OH}$ = driver dependent (GV <sub>DD</sub> _OV <sub>DD</sub> = 3.3 V)	V <sub>OH</sub>	2.4	_	V	4
Output low voltage	$I_{OL}$ = driver dependent (GV <sub>DD</sub> _OV <sub>DD</sub> = 3.3 V)	V <sub>OL</sub>		0.4	V	4

**Table 3. DC Electrical Specifications** 



# 4.3 **Power Characteristics**

Table 5 provides preliminary estimated power consumption data for the MPC8241.

PCI Bus Clock/Memory Bus Clock CPU Clock Frequency (MHz)					Unit	Notes			
	33/66/133	33/66/166	33/66/200	33/100/200	66/100/200	66/66/ 266	66/133/ 266		
Typical	0.7	0.8	1.0	1.0	1.0	1.5	1.8	W	1, 5
Max—CFP	0.8	1.0	1.2	1.3	1.3	1.9	2.1	W	1, 2
Max—INT	0.8	0.9	1.0	1.2	1.2	1.6	1.8	W	1, 3
Doze	0.5	0.6	0.7	0.8	0.8	1.0	1.3	W	1, 4, 6
Nap	0.2	0.2	0.3	0.4	0.4	0.4	0.7	W	1, 4, 6
Sleep	0.2	0.2	0.2	0.2	0.3	0.2	0.4	W	1, 4, 6
I/O Power Supplies <sup>7</sup>									
Мо	de		Minimum			Maximum		Unit	Notes
$\rm GV_{\rm DD} - \rm OV_{\rm DD}$			500			1130		mW	8

### Table 5. Preliminary Power Consumption

#### Notes:

1. The values include  $V_{DD}\!,\,AV_{DD}\!,$  and  $AV_{DD}\!2$  but do not include I/O supply power.

- Maximum—FP power is measured at V<sub>DD</sub> = 1.9 V with dynamic power management enabled while running an entirely cache-resident, looping, floating-point multiplication instruction.
- 3. Maximum—INT power is measured at V<sub>DD</sub> = 1.9 V with dynamic power management enabled while running entirely cache-resident, looping, integer instructions.
- 4. Power saving mode maximums are measured at  $V_{DD}$  = 1.9 V while the device is in doze, nap, or sleep mode.
- 5. Typical power is measured at V<sub>DD</sub> = AV<sub>DD</sub> = 1.8 V, GV<sub>DD</sub>\_OV<sub>DD</sub> = 3.3 V where a nominal FP value, a nominal INT value, and a value where there is a continuous flush of cache lines with alternating ones and zeros on 64-bit boundaries to local memory are averaged.
- 6. Power saving mode data measured with only two PCI\_CLKs and two SDRAM\_CLKs enabled.
- 7. Power consumption of PLL supply pins ( $AV_{DD}$  and  $AV_{DD}$ 2) < 15 mW, guaranteed by design, but not tested.
- The typical maximum GV<sub>DD</sub>\_OV<sub>DD</sub> value resulted from the MPC8241 operating at the fastest frequency combination of 66:133:266 (PCI:Mem:CPU) MHz and performing continuous flushes of cache lines with alternating ones and zeros to PCI memory and on 64-bit boundaries to local memory.



## 4.4 Thermal Characteristics

Table 6 provides the package thermal characteristics for the MPC8241. For details, see Section 7.7, "Thermal Management."

Rating	Thermal Test Board Description	Symbol	Value <sup>7</sup> (166- and 200-MHz Parts)	Value <sup>7</sup> (266-MHz Part)	Unit	Notes
Junction-to-ambient natural convection	Single-layer board (1s)	$R_{ extsf{ heta}JA}$	38	28	°C/W	1, 2
Junction-to-ambient natural convection	Four-layer board (2s2p)	$R_{ heta JMA}$	25	20	°C/W	1, 3
Junction-to-ambient (@200 ft/min)	Single-layer board (1s)	$R_{ extsf{ heta}JMA}$	31	22	°C/W	1, 3
Junction-to-ambient (@200 ft/min)	Four-layer board (2s2p)	$R_{ extsf{ heta}JMA}$	22	17	°C/W	1, 3
Junction-to-board (bottom)	Four-layer board (2s2p)	$R_{ extsf{ heta}JB}$	17	11	°C/W	4
Junction-to-case (top)	Single-layer board (1s)	$R_{ extsf{ heta}JC}$	8	7	°C/W	5
Junction-to-package top	Natural convection	$\Psi_{JT}$	2	2	°C/W	6

### Table 6. Thermal Characterization Data

Notes:

1. Junction temperature is a function of on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, airflow, power dissipation of other components on the board, and board thermal resistance.

- 2. Per SEMI G38-87 and EIA/JESD51-2 with the board horizontal.
- 3. Per EIA/JESD51-6 with the board horizontal.
- 4. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
- 5. Indicates the average thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1) with the cold plate temperature used for the case temperature.
- 6. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per EIA/JESD51-2.
- 7. Note that the 166- and 200-MHz parts are in a two-layer package and the 266-MHz part is in a four-layer package, which causes the two package types to have different thermal characterization data.

### 4.5 AC Electrical Characteristics

After fabrication, functional parts are sorted by maximum processor core frequency as shown in Table 7 and tested for conformance to the AC specifications for that frequency. The processor core frequency is determined by the bus (PCI\_SYNC\_IN) clock frequency and the settings of the PLL\_CFG[0:4] signals. Parts are sold by maximum processor core frequency. See Section 8, "Ordering Information."



Register settings that define each DLL mode are shown in Table 9.

DLL Mode	Bit 2 of Configuration Register at 0x76	Bit 7 of Configuration Register at 0x72
Normal tap delay, No DLL extend	0	0
Normal tap delay, DLL extend	0	1
Max tap delay, No DLL extend	1	0
Max tap delay, DLL extend	1	1

Table 9. DLL Mode Definition

The DLL\_MAX\_DELAY bit can lengthen the amount of time through the delay line by increasing the time between each of the 128 tap points in the delay line. Although this increased time makes it easier to guarantee that the reference clock is within the DLL lock range, there may be slightly more jitter in the output clock of the DLL if the phase comparator shifts the clock between adjacent tap points. Refer to the Freescale application note AN2164, *MPC8245/MPC8241 Memory Clock Design Guidelines: Part 1*, for details on DLL modes and memory design.

The value of the current tap point after the DLL locks can be determined by reading bits 6–0 (DLL\_TAP\_COUNT) of the DLL tap count register (DTCR, located at offset 0xE3). These bits store the value (binary 0 through 127) of the current tap point and can indicate whether the DLL advances or decrements as it maintains the DLL lock. Therefore, for evaluation purposes, DTCR can be read for all DLL modes that support the  $T_{loop}$  value used for the trace length of SDRAM\_SYNC\_OUT to SDRAM\_SYNC\_IN. The DLL mode with the smallest tap point value in the DTCR should be used because the bigger the tap point value, the more jitter that can be expected for clock signals. Keeping a DLL mode locked below tap point decimal 12 is not recommended.





Figure 7. DLL Locking Range Loop Delay versus Frequency of Operation for DLL\_Extend=0 and Normal Tap Delay



Figure 8. DLL Locking Range Loop Delay versus Frequency of Operation for DLL\_Extend=1 and Normal Tap Delay





Figure 9. DLL Locking Range Loop Delay versus Frequency of Operation for DLL\_Extend=0 and Max Tap Delay



Figure 10. DLL Locking Range Loop Delay versus Frequency of Operation for DLL\_Extend=1 and Max Tap Delay

### 4.5.2 Input AC Timing Specifications

Table 10 provides the input AC timing specifications at recommended operating conditions (see Table 2) with  $LV_{DD} = 3.3 V \pm 0.3 V$ . See Figure 11 and Figure 12.

Num	Characteristic	Min	Мах	Unit	Notes
10a	PCI input signals valid to PCI_SYNC_IN (input setup)	3.0		ns	1, 3
10b	Memory input signals valid to sys_logic_clk (input setup)				

### **Table 10. Input AC Timing Specifications**

Num	Characteristic	Min	Max	Unit	Notes
14b	<i>sys_logic_clk</i> to output high impedance (for all others)		4.0	ns	2

#### Table 11. Output AC Timing Specifications (continued)

Notes:

- 1. All PCI signals are measured from  $GV_{DD}$ – $OV_{DD}$ /2 of the rising edge of PCI\_SYNC\_IN to 0.285 ×  $GV_{DD}$ – $OV_{DD}$  or 0.615 ×  $GV_{DD}$ – $OV_{DD}$  of the signal in question for 3.3 V PCI signaling levels. See Figure 12.
- 2. All memory and related interface output signal specifications are specified from the VM = 1.4 V of the rising edge of the memory bus clock, sys\_logic\_clk to the TTL level (0.8 or 2.0 V) of the signal in question. sys\_logic\_clk is the same as PCI\_SYNC\_IN in 1:1 mode, but is twice the frequency in 2:1 mode (processor/memory bus clock rising edges occur on every rising and falling edge of PCI\_SYNC\_IN). See Figure 11.
- 3. PCI bused signals are composed of the following signals: LOCK, IRDY, C/BE[3:0], PAR, TRDY, FRAME, STOP, DEVSEL, PERR, SERR, AD[31:0], REQ[4:0], GNT[4:0], IDSEL, and INTA.
- 4. To meet minimum output hold specifications relative to PCI\_SYNC\_IN for both 33- and 66-MHz PCI systems, the MPC8241 has a programmable output hold delay for PCI signals (the PCI\_SYNC\_IN to output valid timing is also affected). The initial value of the output hold delay is determined by the values on the MCP and CKE reset configuration signals; the values on these two signals are inverted and subsequently stored as the initial settings of PCI\_HOLD\_DEL = PMCR2[5, 4] (power management configuration register 2 <0x72>), respectively. Because MCP and CKE have internal pull-up resistors, the default value of PCI\_HOLD\_DEL after reset is 0b00. Additional output hold delay values are available by programming the PCI\_HOLD\_DEL value of the PMCR2 configuration register. See Figure 15 for PCI\_HOLD\_DEL effect on output valid and hold time.

Figure 14 provides the AC test load for the MPC8241.



Figure 14. AC Test Load for the MPC8241



Package Description

# 5.2 Pin Assignments and Package Dimensions

Figure 24 shows the top surface, side profile, and pinout of the MPC8241, 357 PBGA ZP package. Note that this is available for Rev. B parts only.



Figure 24. MPC8241 Package Dimensions and Pinout Assignments (ZP Package)



Package Description

# 5.3 Pinout Listings

Table 16 provides the pinout listing for the MPC8241, 357 PBGA package.

Signal Name	Package Pin Number	Pin Type	Power Supply	Output Driver Type	Notes		
PCI Interface Signals							
C/BE[3:0]	V11 V7 W3 R3	I/O	GV <sub>DD</sub> OV <sub>DD</sub>	DRV_PCI	1, 2		
DEVSEL	U6	I/O	$GV_{DD}OV_{DD}$	DRV_PCI	2, 3		
FRAME	Т8	I/O	GV <sub>DD</sub> OV <sub>DD</sub>	DRV_PCI	2, 3		
IRDY	U7	I/O	$GV_{DD}OV_{DD}$	DRV_PCI	2, 3		
LOCK	V6	Input	$GV_{DD}OV_{DD}$	—	3		
AD[31:0]	U13 V13 U11 W14 V14 U12 W10 T10 V10 U9 V9 W9 W8 T9 W7 V8 V4 W4 V3 V2 T5 R6 V1 T2 U3 P3 T4 R1 T3 R4 U2 U1	I/O	GV <sub>DD</sub> _OV <sub>DD</sub>	DRV_PCI	1, 2		
PAR	R7	I/O	$GV_{DD}OV_{DD}$	DRV_PCI	2		
<u>GNT</u> [3:0]	W15 U15 W17 V12	Output	$\rm GV_{\rm DD} - \rm OV_{\rm DD}$	DRV_PCI	1, 2		
GNT4/DA5	T11	Output	$GV_{DD}OV_{DD}$	DRV_PCI	2, 4, 5		
REQ[3:0]	V16 U14 T15 V15	Input	$\mathrm{GV}_{\mathrm{DD}}\mathrm{-}\mathrm{OV}_{\mathrm{DD}}$	—	1, 6		
REQ4/DA4	W13	I/O	$\mathrm{GV}_{\mathrm{DD}}\mathrm{-}\mathrm{OV}_{\mathrm{DD}}$	—	5, 6		
PERR	Τ7	I/O	$\rm GV_{\rm DD} - \rm OV_{\rm DD}$	DRV_PCI	2, 3, 7		
SERR	U5	I/O	$GV_{DD}OV_{DD}$	DRV_PCI	2, 3, 8		
STOP	W5	I/O	$GV_{DD}OV_{DD}$	DRV_PCI	2, 3		
TRDY	W6	I/O	$GV_{DD}OV_{DD}$	DRV_PCI	2, 3		
INTA	T12	Output	$GV_{DD}OV_{DD}$	DRV_PCI	2, 8		
IDSEL	U10	Input	$\rm GV_{\rm DD} - \rm OV_{\rm DD}$	_			
	Memory Int	erface Sign	als				
MDL[0:31]	M19 M17 L16 L17 K18 J18 K17 K16 J15 J17 H18 F16 H16 H15 G17 D19 B3 C4 C2 D3 G5 E1 H5 E2 F1 F2 G2 J5 H1 H4 J4 J1	I/O	GV <sub>DD</sub> _OV <sub>DD</sub>	DRV_STD_MEM	1, 9		
MDH[0:31]	M18 L18 L15 K19 K15 J19 J16 H17 G19 G18 G16 D18 F18 E18 G15 E15 C3 D4 E5 F5 D1 E4 D2 E3 F4 G3 G4 G1 H2 J3 J2 K5	I/O	GV <sub>DD</sub> _OV <sub>DD</sub>	DRV_STD_MEM	1		
DQM[0:7]	A18 B18 A6 C7 D15 D14 A9 B8	Output	$GV_{DD}OV_{DD}$	DRV_MEM_CTRL	1		
<u>CS</u> [0:7]	A17 B17 C16 C17 C9 C8 A10 B10	Output	GV <sub>DD</sub> _OV <sub>DD</sub>	DRV_MEM_CTRL	1		
FOE	A7	I/O	GV <sub>DD</sub> OV <sub>DD</sub>	DRV_MEM_CTRL	10, 11		
RCS0	C10	Output	$GV_{DD}OV_{DD}$	DRV_MEM_CTRL	10, 11		

### Table 16. MPC8241 Pinout Listing



		266-MHz Part <sup>9</sup>			Multi	pliers
Ref <sup>2</sup>	PLL_ CFG[0:4] <sup>10,11</sup>	PCI Clock Input (PCI_SYNC_IN) Range <sup>1</sup> (MHz)	Periph Logic/ Mem Bus Clock Range (MHz)	CPU Clock Range (MHz)	PCI-to-Mem (Mem VCO)	Mem-to-CPU (CPU VCO)
1F	11111 <sup>8</sup>	Not usable			Off	Off

Table 18. PLL Configurations (266-MHz Parts) (continued)

### Notes:

- 1. Limited by maximum PCI input frequency (66 MHz).
- 2. Note the impact of the relevant revisions for modes 7 and 1E.
- 3. Limited by minimum memory VCO frequency (132 MHz).
- 4. Limited due to maximum memory VCO frequency (352 MHz).
- 5. Limited by maximum CPU operating frequency.
- 6. Limited by minimum CPU VCO frequency (300 MHz).
- 7. Limited by maximum CPU VCO frequency (704 MHz).
- 8. In clock off mode, no clocking occurs inside the MPC8241, regardless of the PCI\_SYNC\_IN input.
- 9. Range values are shown rounded down to the nearest whole number (decimal place accuracy removed) for clarity.
- 10.PLL\_CFG[0:4] settings that are not listed are reserved.
- 11.Bits 7-4 of register offset <0xE2> contain the PLL\_CFG[0:4] setting value.
- 12.In PLL bypass mode, the PCI\_SYNC\_IN input signal clocks the internal processor directly, the peripheral logic PLL is disabled, and the bus mode is set for 1:1 (PCI:Mem) mode operation. This mode is intended for hardware modeling. The AC timing specifications in this document do not apply in PLL bypass mode.
- 13.In dual PLL bypass mode, the PCI\_SYNC\_IN input signal clocks the internal peripheral logic directly, the peripheral logic PLL is disabled, and the bus mode is set for 1:1 (PCI\_SYNC\_IN:Mem) mode operation. In this mode, the OSC\_IN input signal clocks the internal processor directly in 1:1 (OSC\_IN:CPU) mode operation and the processor PLL is disabled. The PCI\_SYNC\_IN and OSC\_IN input clocks must be externally synchronized. This mode is intended for hardware modeling. The AC timing specifications in this document do not apply in dual PLL bypass mode.
- 14.Limited by minimum CPU operating frequency (100 MHz).
- 15.Limited by minimum memory bus frequency (50 MHz).

# 7 System Design Information

This section provides electrical and thermal design recommendations for successful application of the MPC8241.

## 7.1 PLL Power Supply Filtering

The AV<sub>DD</sub> and AV<sub>DD</sub>2 power signals on the MPC8241 provide power to the peripheral logic/memory bus PLL and the MPC603e processor PLL. To ensure stability of the internal clocks, the power supplied to the AV<sub>DD</sub> and AV<sub>DD</sub>2 input signals should be filtered of any noise in the 500 kHz to 10 MHz resonant frequency range of the PLLs. Two separate circuits similar to the one shown in Figure 26 using surface mount capacitors with minimum effective series inductance (ESL) is recommended for AV<sub>DD</sub> and AV<sub>DD</sub>2 power signal pins. In *High Speed Digital Design: A Handbook of Black Magic* (Prentice Hall, 1993), Dr. Howard Johnson recommends using multiple small capacitors of equal value instead of multiple values.



Place the circuits as closely as possible to the respective input signal pins to minimize noise coupled from nearby circuits. Routing from the capacitors to the input signal pins should be as direct as possible with minimal inductance of vias.



Figure 26. PLL Power Supply Filter Circuit

### 7.2 Decoupling Recommendations

Dynamic power management, large address and data buses, and high operating frequencies enable the MPC8241 to generate transient power surges and high frequency noise in its power supply, especially while driving large capacitive loads. This noise must be prevented from reaching other components in the MPC8241 system, and the MPC8241 itself requires a clean, tightly regulated source of power. Therefore, place at least one decoupling capacitor at each  $V_{DD}$ ,  $GV_{DD}$ – $OV_{DD}$ , and  $LV_{DD}$  pin. These decoupling capacitors receive their power from dedicated power planes in the PCB, using short traces to minimize inductance. These capacitors should have a value of 0.1 µF. To minimize lead inductance, use only ceramic SMT (surface mount technology) capacitors, preferably 0508 or 0603, on which connections are made along the length of the part.

In addition, distribute several bulk storage capacitors around the PCB to feed the  $V_{DD}$ ,  $GV_{DD}$ – $OV_{DD}$ , and  $LV_{DD}$  planes and enable quick recharging of the smaller chip capacitors. These bulk capacitors should have a low ESR (equivalent series resistance) rating to ensure the necessary quick response time, and should be connected to the power and ground planes through two vias to minimize inductance. Freescale recommends using bulk capacitors: 100–330 µF (AVX TPS tantalum or Sanyo OSCON).

### 7.3 Connection Recommendations

To ensure reliable operation, connect unused inputs to an appropriate signal level. Tie unused active-low inputs to  $OV_{DD}$ . Connect unused active-high inputs to GND. All no connect (NC) signals must remain unconnected.

Power and ground connections must be made to all external V<sub>DD</sub>, GV<sub>DD</sub>, GV<sub>DD</sub>, LV<sub>DD</sub>, and GND pins.

The PCI\_SYNC\_OUT signal is to be routed halfway out to the PCI devices and then returned to the PCI\_SYNC\_IN input.

The SDRAM\_SYNC\_OUT signal is to be routed halfway out to the SDRAM devices and then returned to the SDRAM\_SYNC\_IN input of the MPC8241. The trace length can be used to skew or adjust the timing window as needed. See the Tundra *Tsi107<sup>TM</sup> Design Guide* (AN1849) and Freescale application notes AN2164/D, *MPC8245/MPC8241 Memory Clock Design Guidelines: Part 1* and AN2746, *MPC8245/MPC8241 Memory Clock Design Guidelines: Part 2* for more details. Note the SDRAM\_SYNC\_IN to PCI\_SYNC\_IN time requirement (see Table 10).



System Design Information



Figure 29. Die Junction-to-Ambient Resistance

The board designer can choose among several types of heat sinks to place on the MPC8241. Several commercially available heat sinks for the MPC8241 are provided by the following vendors:

Aavid Thermalloy	603-224-9988
80 Commercial St.	
Concord, NH 03301	
Internet: www.aavidthermalloy.com	
Alpha Novatech 473 Sapena Ct. #15 Santa Clara, CA 95054 Internet: www.alphanovatech.com	408-749-7601
International Electronic Research Corporation (IERC) 413 North Moss St. Burbank, CA 91502 Internet: www.ctscorp.com	818-842-7277
Tyco Electronics	800-522-6752
Chip Coolers <sup>TM</sup>	
P.O. Box 3668 Harrisburg, PA 17105-3668 Internet: www.chipcoolers.com	
Wakefield Engineering	603-635-5102
33 Bridge St.	
Pelham, NH 03076	
Internet: www.wakefield.com	

Selection of an appropriate heat sink depends on thermal performance at a given air velocity, spatial volume, mass, attachment method, assembly, and cost. Other heat sinks offered by Aavid Thermalloy, Alpha Novatech, IERC, Chip Coolers, and Wakefield Engineering offer different heat sink-to-ambient thermal resistances, and may or may not need airflow.





### 7.7.1 Internal Package Conduction Resistance

For the PBGA, die-up, packaging technology, shown in Figure 28, the intrinsic conduction thermal resistance paths are as follows:

- The die junction-to-case thermal resistance
- The die junction-to-ball thermal resistance

Figure 30 depicts the primary heat transfer path for a package with an attached heat sink mounted to a printed-circuit board.



<sup>(</sup>Note the internal versus external package resistance)

### Figure 30. PBGA Package with Heat Sink Mounted to a Printed-Circuit Board

For this die-up, wire-bond PBGA package, heat generated on the active side of the chip is conducted mainly through the mold cap, the heat sink attach material (or thermal interface material), and finally through the heat sink where forced-air convection removes it.

### 7.7.2 Adhesives and Thermal Interface Materials

A thermal interface material should be used between the top of the mold cap and the bottom of the heat sink minimizes thermal contact resistance. For applications that attach the heat sink by a spring clip mechanism, Figure 31 shows the thermal performance of three thin-sheet thermal-interface materials (silicone, graphite/oil, floroether oil), a bare joint, and a joint with thermal grease as a function of contact pressure. As shown, the performance of these thermal interface materials improves with increasing contact pressure. Thermal grease significantly reduces the interface thermal resistance. That is, the bare joint offers a thermal resistance approximately seven times greater than the thermal grease joint.

A spring clip attaches heat sinks to holes in the printed-circuit board (see Figure 28). Therefore, the synthetic grease offers the best thermal performance, considering the low interface pressure. The selection of any thermal interface material depends on factors such as thermal performance requirements, manufacturability, service temperature, dielectric properties, and cost.



System Design Information



Figure 31. Thermal Performance of Select Thermal Interface Material

The board designer can choose among several types of thermal interface. Heat sink adhesive materials are selected on the basis of high conductivity and adequate mechanical strength to meet equipment shock/vibration requirements. Several commercially-available thermal interfaces and adhesive materials are provided by the following vendors:

The Bergquist Company 18930 West 78 <sup>th</sup> St	800-347-4572
Chanhassen, MN 55317	
Internet: www.bergquistcompany.com	
Chomerics, Inc.	781-935-4850
77 Dragon Ct.	
Woburn, MA 01888-4014	
Internet: www.chomerics.com	
Dow-Corning Corporation	800-248-2481
Dow-Corning Electronic Materials	
2200 W. Salzburg Rd.	
Midland, MI 48686-0997	
Internet: www.dow.com	



## 8.1 Part Numbers Fully Addressed by This Document

Table 19 provides the Freescale part numbering nomenclature for the MPC8241. Note that the individual part numbers correspond to a maximum processor core frequency. For available frequencies, contact your local Freescale sales office. In addition to the processor frequency, the part numbering scheme also includes an application modifier that may specify special application conditions. Each part number also contains a revision code that refers to the die mask revision number. Read the Revision ID register at address offset 0x08 to determine the revision level.

MPC	nnnn	L	XX	nnn	X
Product Code	Part Identifier	Process Descriptor	Package <sup>1</sup>	Processor Frequency <sup>2</sup> (MHz)	Revision Level
MPC	8241	L = Standard spec. 0° to 105°C	ZQ = thick substrate and thick mold cap PBGA (two layers)	166, 200 1.8 V ± 100 mV	D:1.4 = Rev. ID:0x14
			ZQ = thick substrate and thick mold cap PBGA (four layers, thermally enhanced)	266 1.8 V ± 100 mV	
			VR = Lead-free version of package	166, 200, 266 1.8 V ± 100 mV	

### **Table 19. Part Numbering Nomenclature**

#### Notes:

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1. See Section 5, "Package Description," for more information on available package types.

2. Processor core frequencies supported by parts addressed by this specification only. Not all parts described in this specification support all core frequencies. Additionally, parts addressed by hardware specifications addendums may support other maximum core frequencies.

## 8.2 Part Numbers Not Fully Addressed by This Document

Parts with application modifiers or revision levels not fully addressed in this specification document are described in separate hardware specifications addendums that supplement and supersede this document (see Table 20).

Table 20. Part Numbers Addressed by MPC8241TXXPNS Series
(Document No. MPC8241ECSO1AD))

MPC	nnnn	Т	XX	nnn	X	
Product Code	Part Identifier	Process Descriptor	Package <sup>1</sup>	Processor Frequency <sup>2</sup> (MHz)	Revision Level	Processor Version Register Value



NP

Revision	Date	Substantive Change(s)		
8	12/19/2005	Document—Imported new template and made minor editoral corrections. Section 4.3.1—Before Figure 7, added paragraph for using DLL mode that provides lowest locked tap point read in 0xE3. Section 4.3.2—After Figure 12, added a sentence to introduce Figure 13. Section 4.3.3—After Table 11, added a sentence to introduce Figure 14. Section 4.3.4—After Table 11, added to the sentence to introduce Figures 16 thru 19. Section 4.3.6—After Table 16, added a sentence to introduce Figures 22 thru 25. Section 5.3—Updated the driver and I/O assignment information for the multiplexed PCI clock and DUART signals. Added note for HRST_CPU and HRST_CTRL, which had been mentioned only in Figure 2. Section 9.2—Updated the part ordering specifications for the extended temperature parts. Also updated Section 9.2 to reflect what we offer for new orders. Updated Figure 34 to match with current part marking format. Section 8.3—Added new section for part marking information.		
7	05/11/2004	Section 4.1.4 —Table 4: Changed the default for drive strength of DRV_STD_MEM. Section 4.3.1 —Table 8: Changed the wording for item 15 description. Section 4.3.4 —Table 10: Changed T <sub>os</sub> range and wording in note 7; Figure 11: changed wording for SDRAM_SYNC_IN description relative to T <sub>OS</sub> .		
6.1		Section 4.3.1 — Table 9: Corrected last row to state the correct description for the bit setting: Max tap delay, DLL extend. Figure 8: Corrected the label name for the DLL graph to state "DLL Locking Range Loop Delay vs. Frequency of Operation for DLL_Extend=1 and Normal Tap Delay"		
6		Section 4.1.2 — Figure 2: Added note 6 and related label for latching of the PLL_CFG signals. Section 4.1.3 — Updated specifications for the input high and input low voltages of PCI_SYNC_IN. Section 4.3.1 — Table 8: Corrected typo for first number 1a to 1; Updated characteristics for the DLL lock range for the default and remaining three DLL locking modes; Reworded note description for note 6. Replaced contents of Table 9 with bit descriptions for the four DLL locking modes. In Figures 7 through 10, updated the DLL locking mode graphs. Section 4.3.2 — Table 10: Changed the name of references for timing parameters from SDRAM_SYNC_IN to <i>sys_logic_clk</i> to be consistent with Figure 11. Followed the same change for note 2. Section 4.3.3 — Table 11: Changed the name of references for timing parameters from SDRAM_SYNC_IN to <i>sys_logic_clk</i> to be consistent with Figure 11. Followed the same change for note 2. Section 5.3 — Table 17: Removed extra listing of DRDY in test/configuration signal list and updated relevant notes for signal in memory Interface signal listing. Updated note #20. Added note 24 for the signals of the UART interface. Section 7.6 — Added relevant notes to this section and updated Figure 29.		
5	_	Section 5.1— Updated package information to include all package offerings. Section 5.2— Included package case outline for ZP (Rev. B) packaging parts. Section 9— Updated Part markings for the offerings of the MPC8241. All sections— Nontechnical reformatting		